

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/678,714	MIHAI ET AL.		
Examiner	Art Unit		
Emeka Ehirim	2166		

SEARCHED					
Class	Subclass	Date	Examiner		
Updated	Updated	8/10/2006	EE		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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(INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
EAST	8/10/2006	EE			
Consulted Pham Khanh (primary)	8/9/2006	EE			
NPL (Google scholar)	8/10/2006	EE			
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